

SL SEMI**SL-FET™**

SLP3N80C / SLF3N80C

800V N-Channel MOSFET

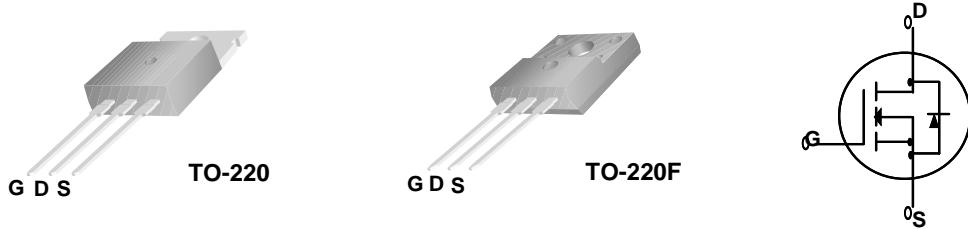
General Description

This Power MOSFET is produced using SL semi's advanced planar stripe DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- 3.0A, 800V, $R_{DS(on)} = 5.00\Omega$ @ $V_{GS} = 10\text{ V}$
- Low gate charge (typical 15nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	SLP3N80C	SLF3N80C	Units
V_{DSS}	Drain-Source Voltage	800		V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$)	3.0	3.0*	A
	- Continuous ($T_C = 100^\circ\text{C}$)	1.8	1.8 *	A
I_{DM}	Drain Current - Pulsed	(Note 1)	12	12*
V_{GSS}	Gate-Source Voltage		± 30	V
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	336	mJ
E_{AR}	Repetitive Avalanche Energy	(Note 1)	10.7	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.0	V/ns
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	107	39	W
	- Derate above 25°C	0.85	0.31	W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	$^\circ\text{C}$

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	SLP3N80C	SLF3N80C	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.17	3.2	$^\circ\text{C}/\text{W}$
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	$^\circ\text{C}/\text{W}$

SLP3N80C / SLF3N80C

Typical Characteristics

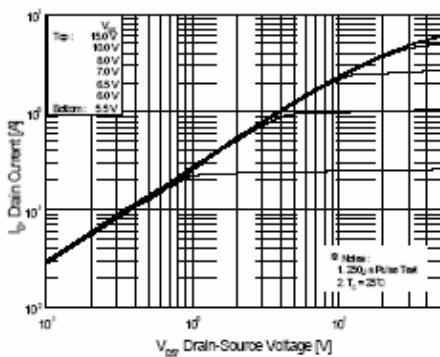


Figure 1. On-Region Characteristics

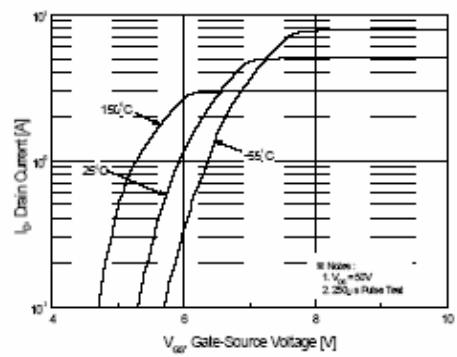


Figure 2. Transfer Characteristics

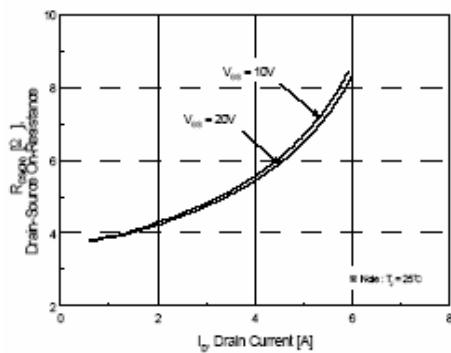


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

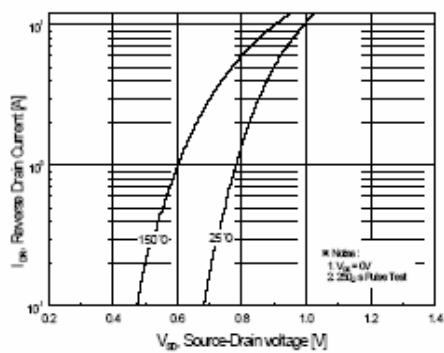


Figure 4. Body Diode Forward Voltage Variation with Source Current

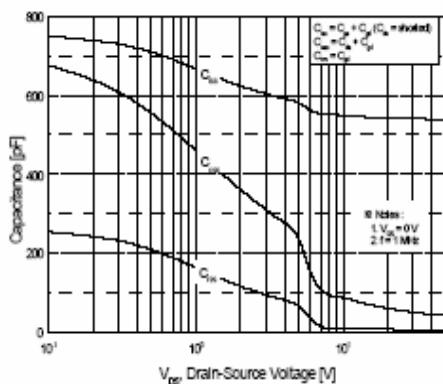


Figure 5. Capacitance Characteristics

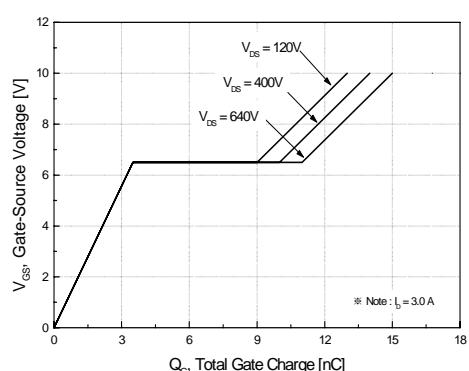


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

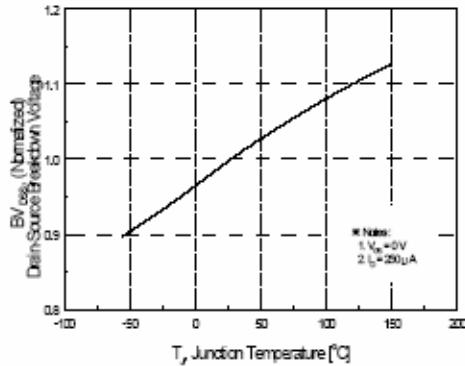


Figure 7. Breakdown Voltage Variation vs Temperature

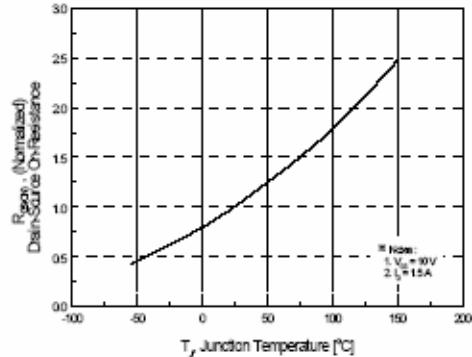


Figure 8. On-Resistance Variation vs Temperature

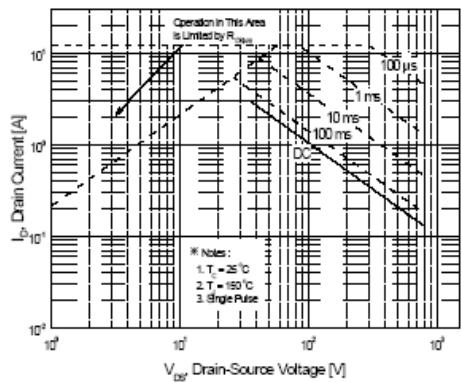


Figure 9-1. Maximum Safe Operating Area for SLP3N80C

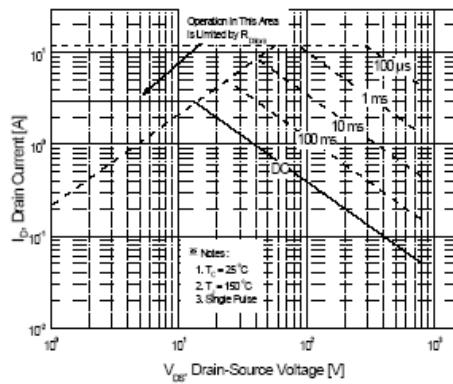


Figure 9-2. Maximum Safe Operating Area for SLF3N80C

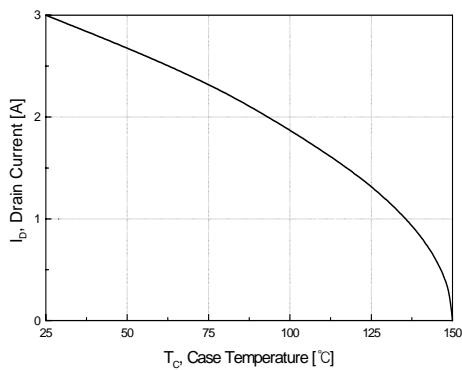


Figure 10. Maximum Drain Current vs Case Temperature

Typical Characteristics (Continued)

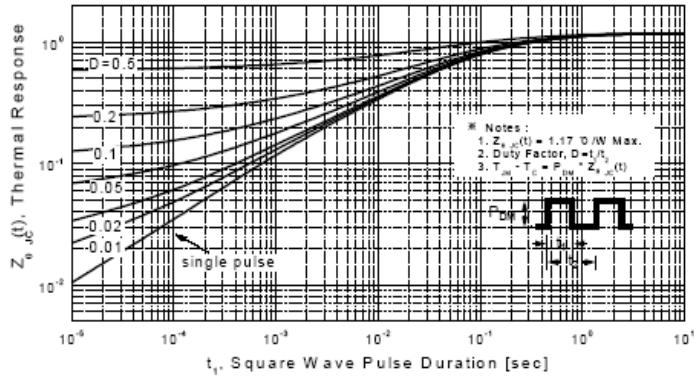


Figure 11-1. Transient Thermal Response Curve
for SLP3N80C

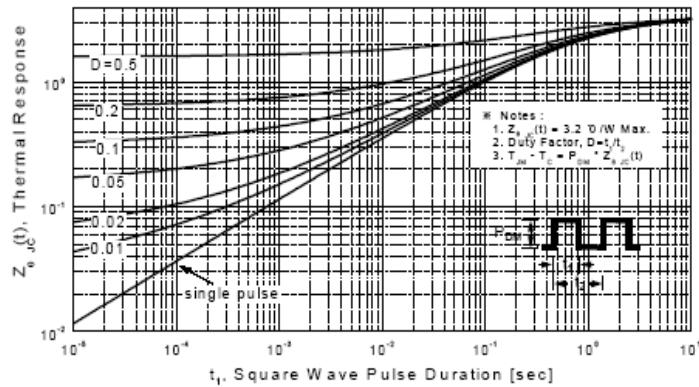
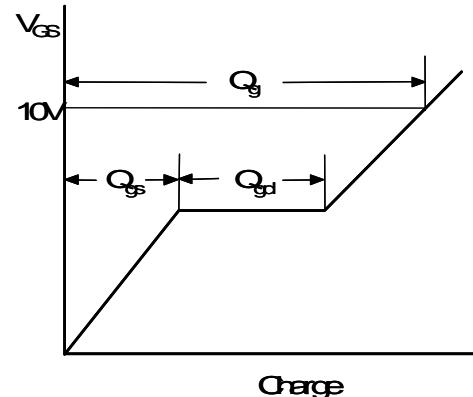
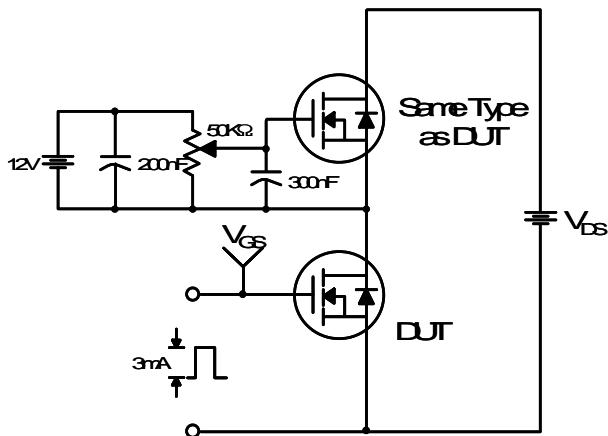
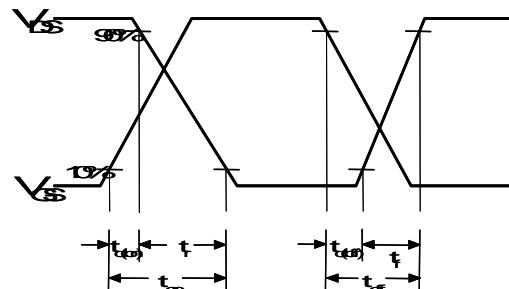
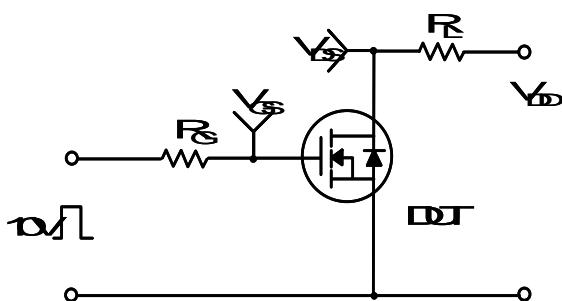


Figure 11-2. Transient Thermal Response Curve
for SLF3N80C

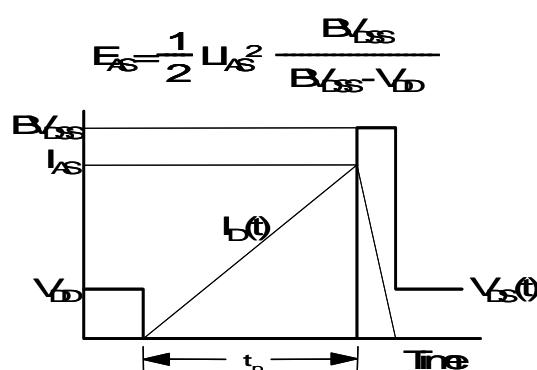
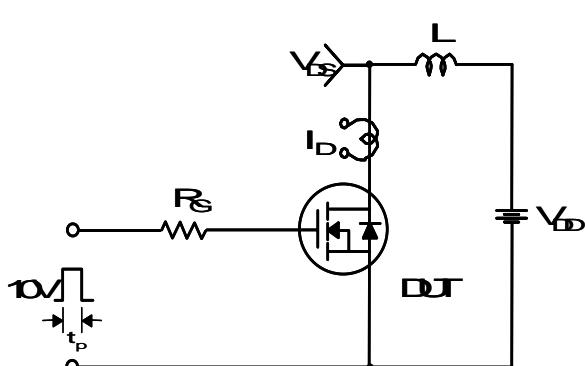
Gate Charge Test Circuit & Waveform



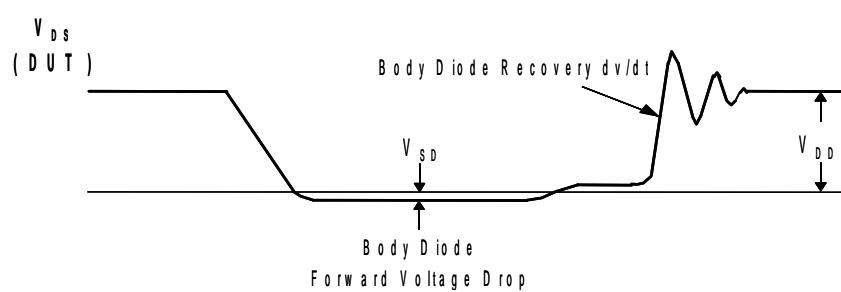
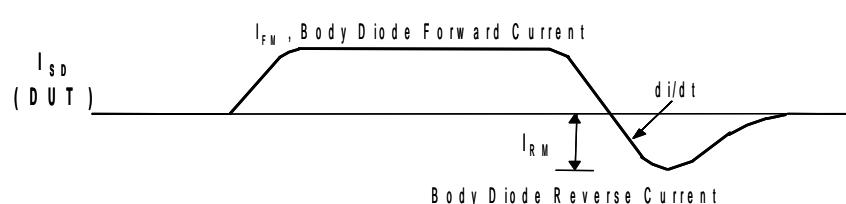
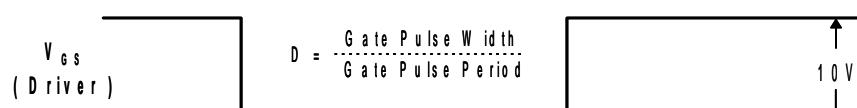
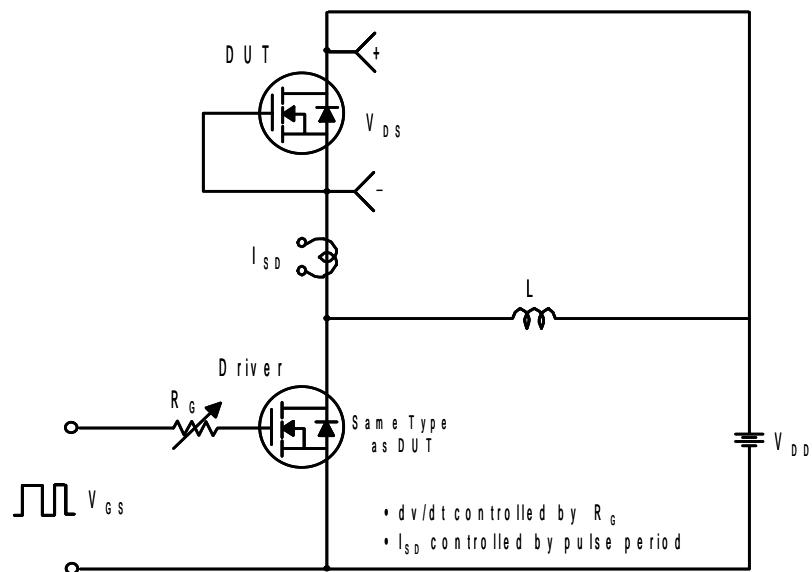
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



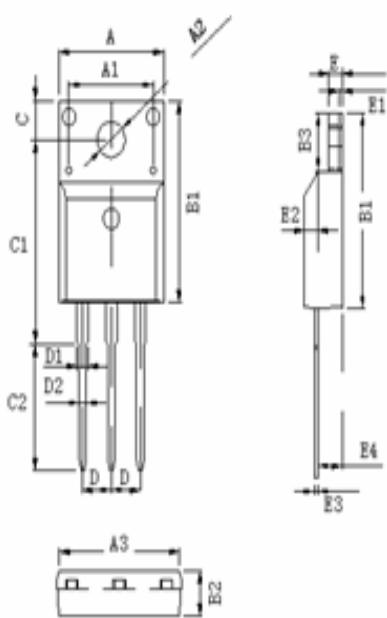
Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package Dimensions

TO-220F

TO-220F 外形尺寸图



DIM.	MILLIMETERS
A	10.03 ± 0.20
A1	7.00
A2	3.12 ± 0.10
A3	9.70 ± 0.20
B1	15.75 ± 0.20
B2	4.72 ± 0.20
B3	6.70 ± 0.20
C	3.30 ± 0.10
C1	15.80 ± 0.20
C2	9.80 ± 0.2
D	Typical 2.54
D1	1.47 (MAX)
D2	0.80 ± 0.10
E	2.55 ± 0.20
E1	0.70
E2	1.00 × 45°
E3	0.50
E4	2.80 ± 0.20